

Application/Control No.	Applicant(s)/Patent under Reexamination
10/707,224	SU ET AL.
Examiner	Art Unit
Matthew G. Kayrish	2627

	SEARCHED				
Class	Subclass	Date	Examiner		
720	638 636 603 619	6/7/2006	MK		
720	612 703	6/7/2006	MK		
720	711 710	6/7/2006	MK		
720	635 634	6/7/2006	мк		
720	715 613	6/7/2006	МК		
720	604 607	6/7/2006	МК		
720	706	6/7/2006	МК		
369	261 30.55	6/7/2006	МК		
369	264 30.57	6/7/2006	MK		
369	30.82 256	6/7/2006	MK		
369	271.1 282	6/7/2006	MK		
360	99.02	6/7/2006	мк		
360	99.06	6/7/2006	MK		
359	824	6/7/2006	МК		

INI	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
720	604	6/7/2006	MK		
720	636 638	6/8/2006	MK		
360	99.02	6/8/2006	мк		
(See Attac	SPG-PUB) ched Search story)	6/8/2006	MK		

SEARCH NOT (INCLUDING SEARCH S)
	DATE	EXMR
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search History)	6/7/2006	MK
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search History)	2/7/2006	MK
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT) (See Attached Search History)	10/28/2005	MK